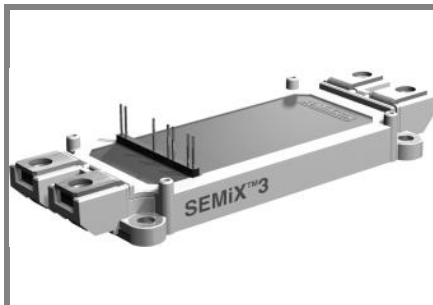


# SEMiX 703GB126HD ...



**SEMiX® 3**

## Trench IGBT Modules

**SEMiX 703GB126HD**

**SEMiX 703GAL126HD**

**SEMiX 703GAR126HD**

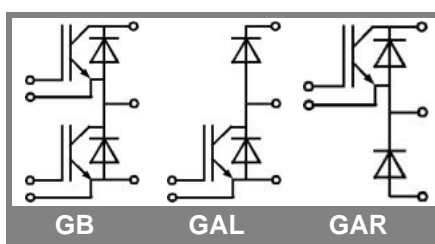
Preliminary Data

### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

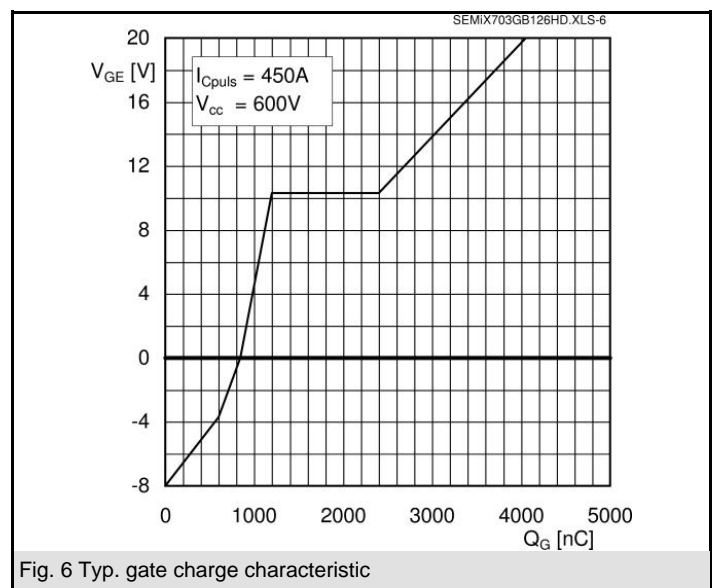
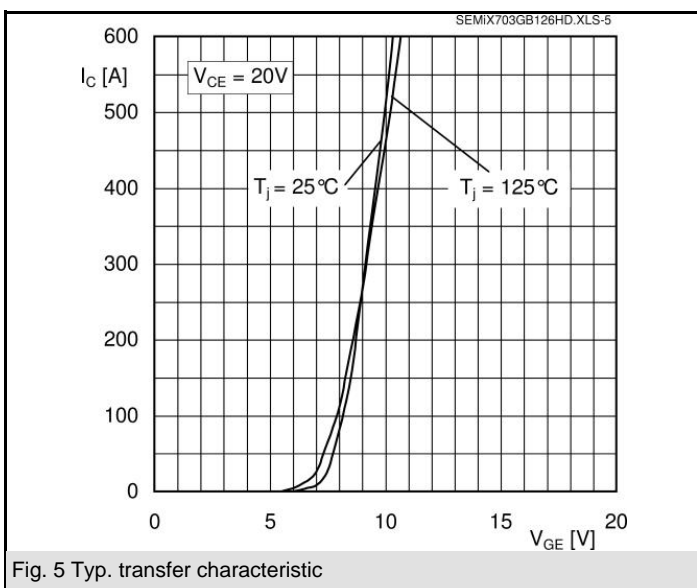
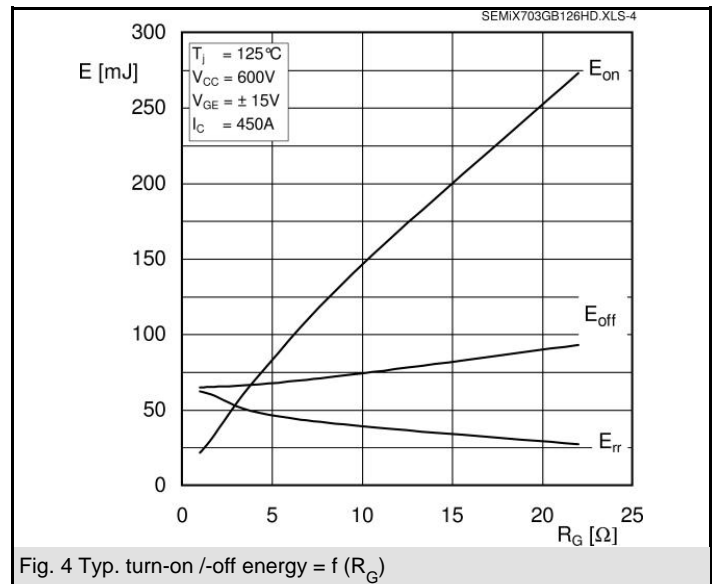
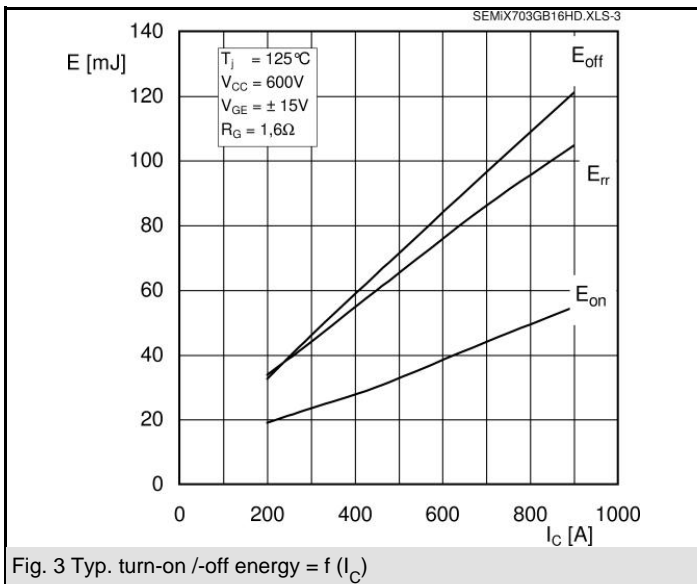
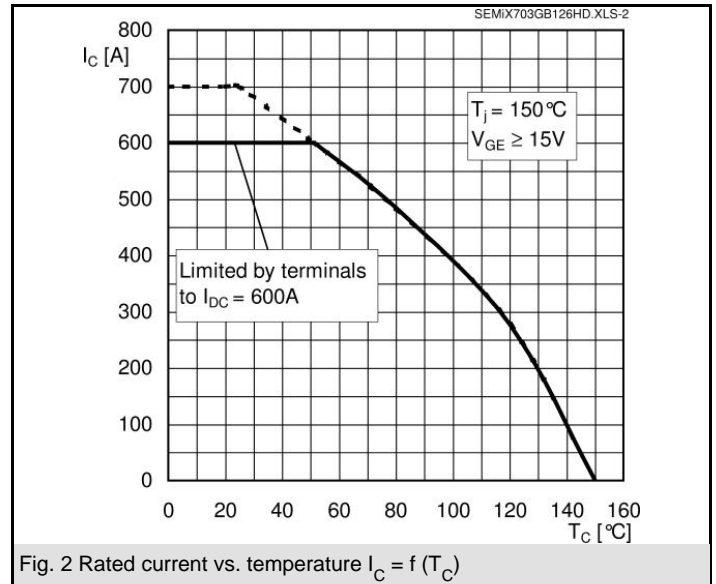
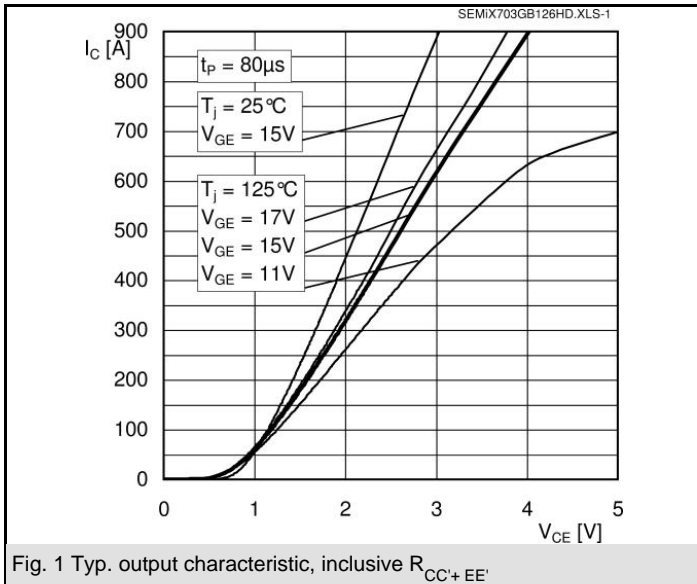
### Typical Applications

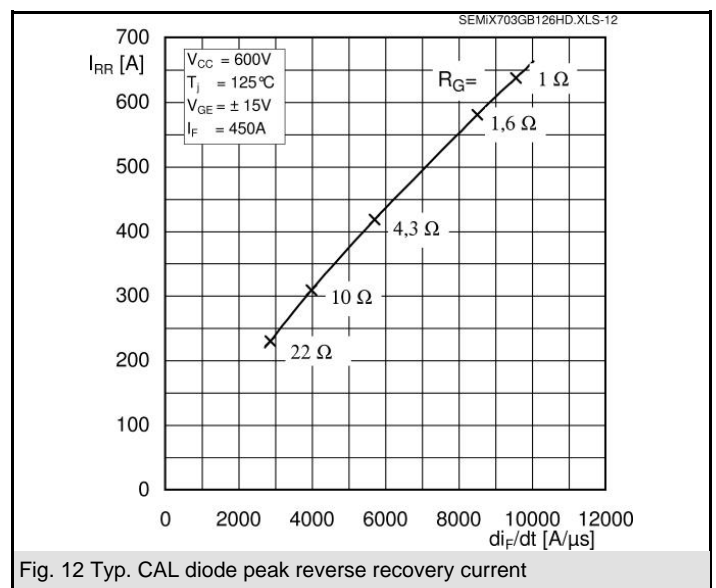
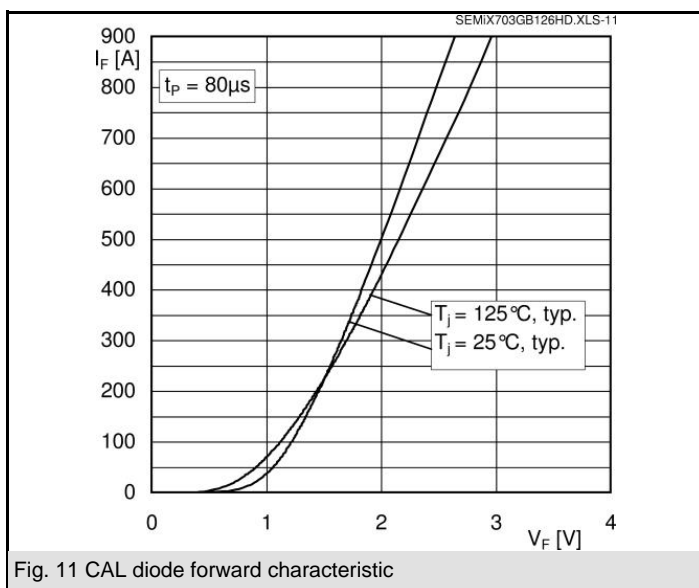
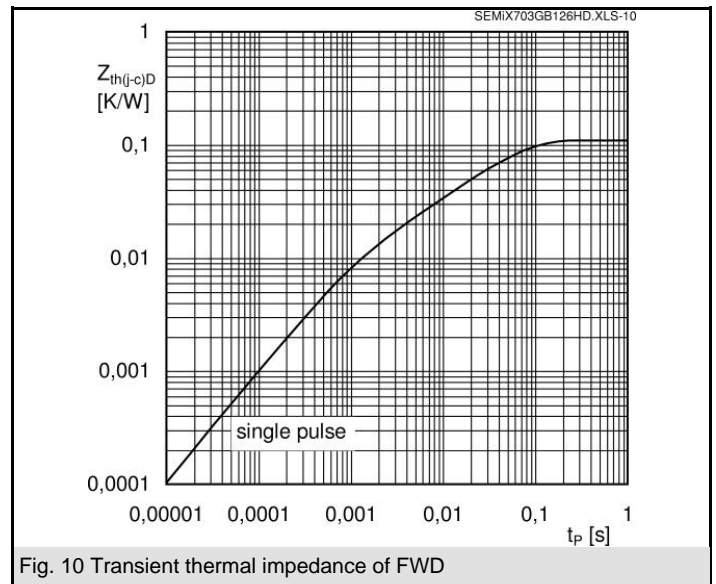
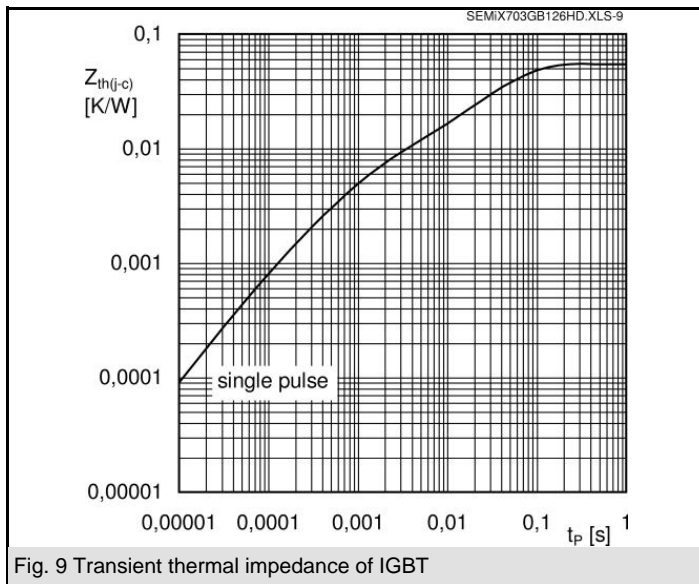
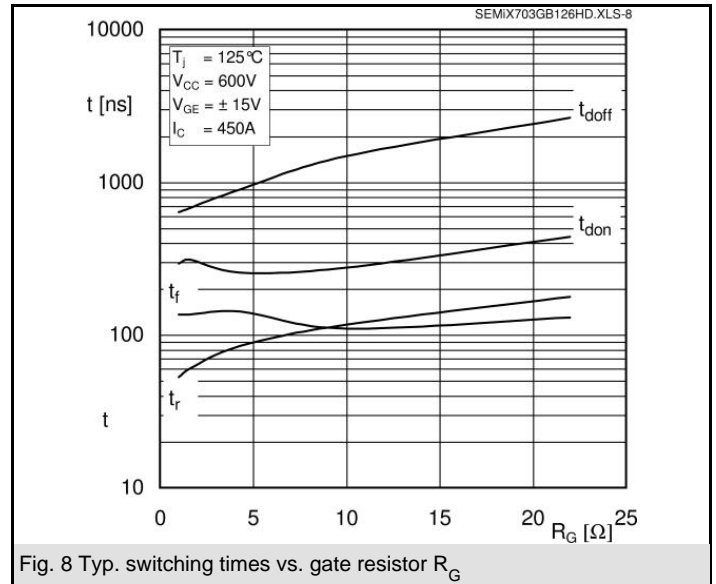
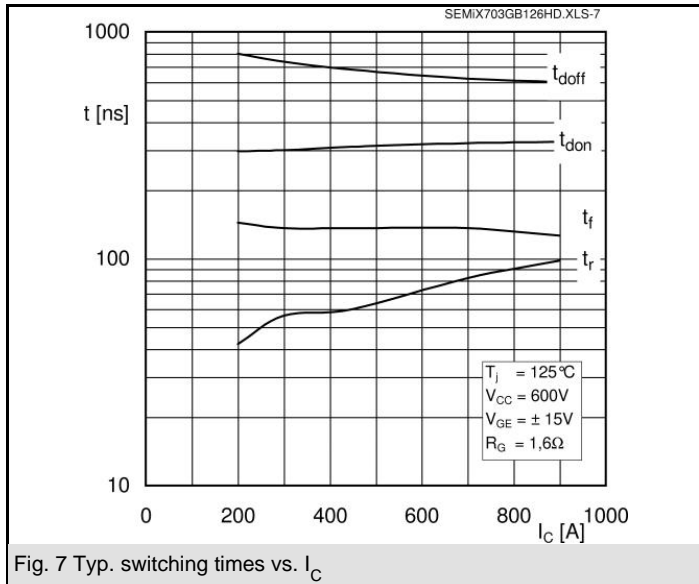
- AC inverter drives
- UPS
- Electronic welders

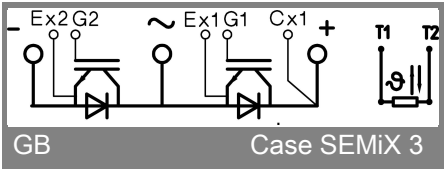
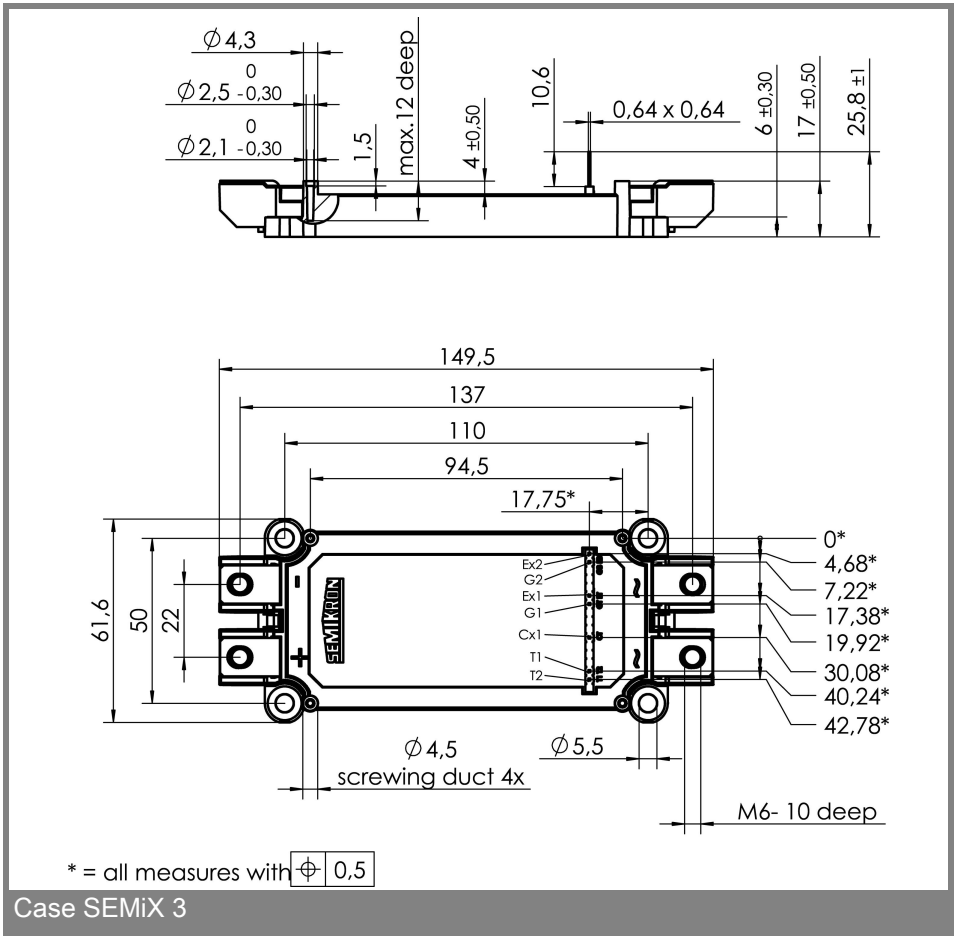
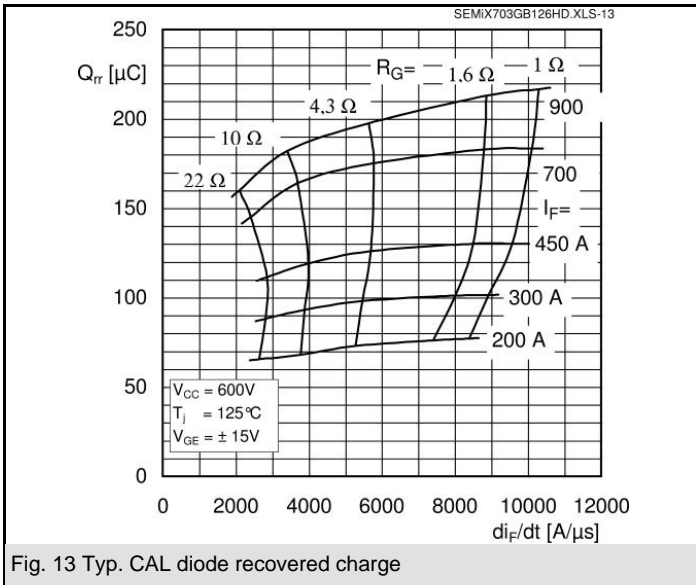


| Absolute Maximum Ratings |   | $T_c = 25\text{ °C}$ , unless otherwise specified |       |
|--------------------------|---|---|-------|
| Symbol                   | Conditions                                      | Values  | Units |
| <b>IGBT</b>              |   |   |       |
| $V_{CES}$                |   | 1200  | V     |
| $I_C$                    | $T_c = 25\text{ (80) °C}$                       | 700 (490)   | A     |
| $I_{CRM}$                | $t_p = 1\text{ ms}$                             | 900   | A     |
| $V_{GES}$                |   | $\pm 20$  | V     |
| $T_{vj}$ ( $T_{stg}$ )   | $T_{OPERATION} \leq T_{stg}$                    | - 40 ... + 150 (125)                              | °C    |
| $V_{isol}$               | AC, 1 min.                                      | 4000  | V     |
| <b>Inverse diode</b>     |   |   |       |
| $I_F$                    | $T_c = 25\text{ (80) °C}$                       | 560 (380)   | A     |
| $I_{FRM}$                | $t_p = 1\text{ ms}$                             | 900   | A     |
| $I_{FSM}$                | $t_p = 10\text{ ms; sin.; } T_j = 25\text{ °C}$ | 2900  | A     |

| Characteristics                |  | $T_c = 25\text{ °C}$ , unless otherwise specified |             |             |       |
|--------------------------------|--|---|-------------|-------------|-------|
| Symbol                         | Conditions   | min.  | typ.        | max.        | Units |
| <b>IGBT</b>                    |  |   |             |             |       |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}, I_C = 18\text{ mA}$  | 5   | 5,8         | 6,5         | V     |
| $I_{CES}$                      | $V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25\text{ (125) °C}$                               |   |             | 0,6         | mA    |
| $V_{CE(TO)}$                   | $T_j = 25\text{ (125) °C}$   |   | 1 (0,9)     | 1,2 (1,1)   | V     |
| $r_{CE}$                       | $V_{GE} = 15\text{ V}, T_j = 25\text{ (125) °C}$                                       |   | 1,45 (2,45) | 2 (2,9)     | mΩ    |
| $V_{CE(sat)}$                  | $I_{Cnom} = 450\text{ A}, V_{GE} = 15\text{ V}, T_j = 25\text{ (125) °C}$ , chip level |   | 1,7 (2)     | 2,15 (2,45) | V     |
| $C_{ies}$                      | under following conditions   |   | 33          |             | nF    |
| $C_{oes}$                      | $V_{GE} = 0, V_{CE} = 25\text{ V}, f = 1\text{ MHz}$                                   |   | 1,7         |             | nF    |
| $C_{res}$                      |  |   | 1,5         |             | nF    |
| $L_{CE}$                       |  |   | 20          |             | nH    |
| $R_{CC'+EE'}$                  | terminal-chip, $T_c = 25\text{ (125) °C}$  |   | 0,7 (1)     |             | mΩ    |
| $t_{d(on)}/t_r$                | $V_{CC} = 600\text{ V}, I_{Cnom} = 450\text{ A}$                                       |   | 310 / 60    |             | ns    |
| $t_{d(off)}/t_f$               | $V_{GE} = \pm 15\text{ V}$   |   | 680 / 135   |             | ns    |
| $E_{on} (E_{off})$             | $R_{Gon} = R_{Goff} = 1,6\text{ Ω}, T_j = 125\text{ °C}$                               |   | 30 (65)     |             | mJ    |
| <b>Inverse diode</b>           |  |   |             |             |       |
| $V_F = V_{EC}$                 | $I_{Fnom} = 450\text{ A}; V_{GE} = 0\text{ V}; T_j = 25\text{ (125) °C}$ , chip level  |   | 1,6 (1,6)   | 1,8 (1,8)   | V     |
| $V_{(TO)}$                     | $T_j = 25\text{ (125) °C}$   |   | 1 (0,8)     | 1,1 (0,9)   | V     |
| $r_T$                          | $T_j = 25\text{ (125) °C}$   |   | 1,3 (1,8)   | 1,6 (2)     | mΩ    |
| $I_{RRM}$                      | $I_{Fnom} = 450\text{ A}; T_j = 25\text{ (125) °C}$                                    |   | (580)       |             | A     |
| $Q_{rr}$                       | $di/dt = 8500\text{ A/μs}$   |   | (130)       |             | μC    |
| $E_{rr}$                       | $V_{GE} = -15\text{ V}$  |   | (60)        |             | mJ    |
| <b>Thermal characteristics</b> |  |   |             |             |       |
| $R_{th(j-c)}$                  | per IGBT   |   |             | 0,055       | K/W   |
| $R_{th(j-c)D}$                 | per Inverse Diode  |   |             | 0,11        | K/W   |
| $R_{th(j-c)FD}$                | per FWD  |   |             |             | K/W   |
| $R_{th(c-s)}$                  | per module   |   | 0,04        |             | K/W   |
| <b>Temperature sensor</b>      |  |   |             |             |       |
| $R_{25}$                       | $T_c = 25\text{ °C}$   |   | 5 ±5%       |             | kΩ    |
| $B_{25/85}$                    | $R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]; T[K]; B$  |   | 3420        |             | K     |
| <b>Mechanical data</b>         |  |   |             |             |       |
| $M_s/M_t$                      | to heatsink (M5) / for terminals (M6)  | 3/2,5   |             | 5 / 5       | Nm    |
| w                              |  |   | 289         |             | g     |







This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.